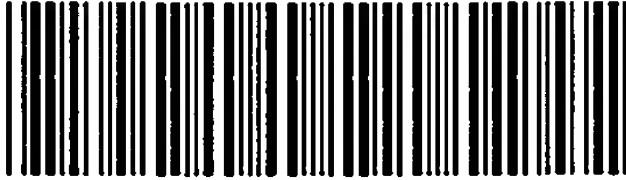


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/660,541	HENG, WAN CHUAN	
	Examiner	Art Unit	
	James W. Cranson	2875	

SEARCHED			
Class	Subclass	Date	Examiner
362	253	2/15/2005	JWC
439	332	2/15/2005	JWC
40	431	2/15/2005	JWC
206	509	2/15/2005	JWC

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
24/\$.CCLS.	2/15/2005	JWC
362/\$.CCLS.	2/15/2005	JWC
439/\$.CCLS.	2/15/2005	JWC